

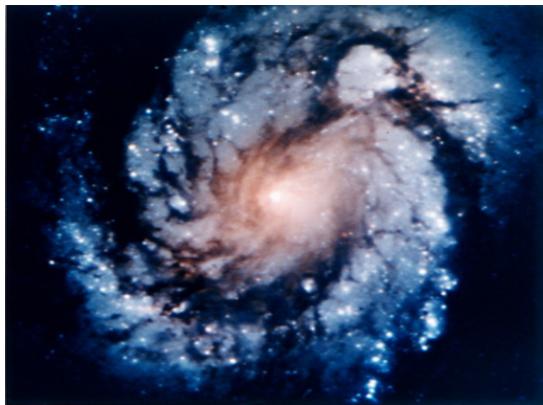
MeV ultrafast electron diffraction and microscopy for the scientific frontier

Dao Xiang

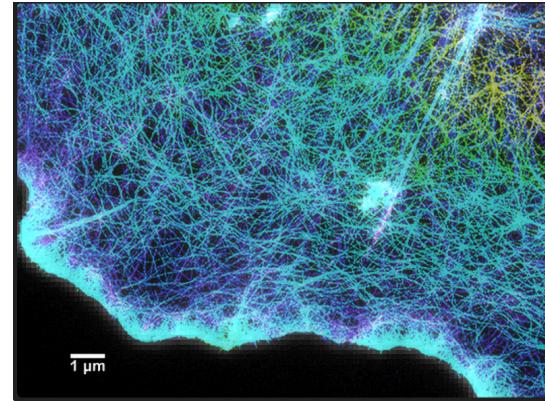
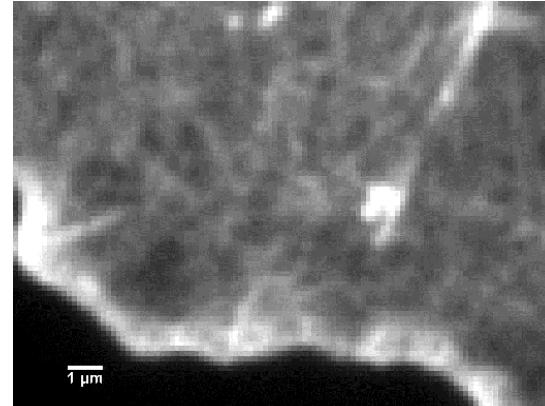
Shanghai Jiao Tong University and
Tsung-Dao Lee Institute

5/21/2019

The quest of resolution



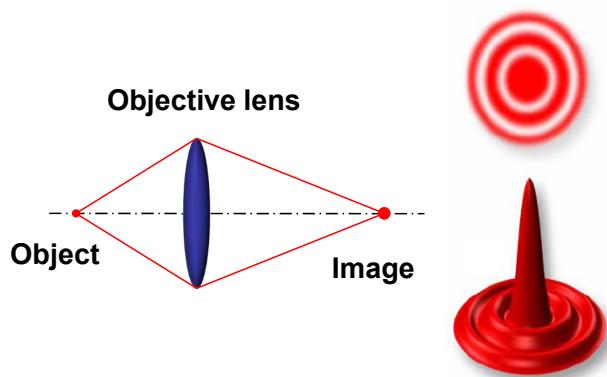
Galaxy by Hubble Space
Telescope



Molecule by super resolution
fluorescence microscopy

Spatial resolution: imaging and diffraction

Imaging

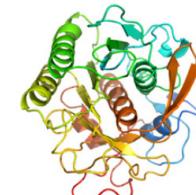
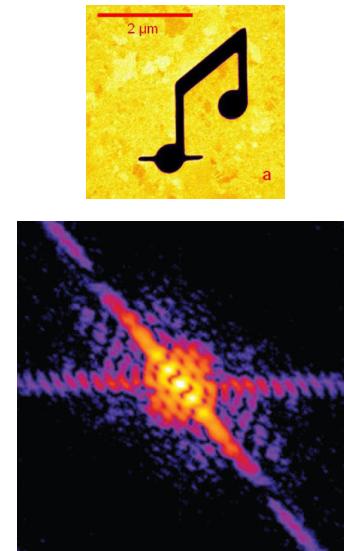
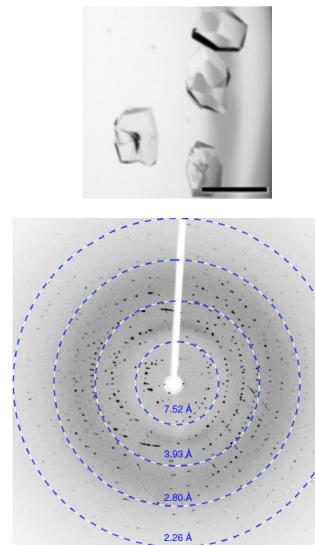


$$\Delta r \approx \frac{\lambda}{2n\sin\alpha}$$

λ : wavelength of incident beam
 $n \cdot \sin(\alpha)$: Numerical Aperture

Resolution: $\lambda/2$
(~200 nm for optical light)

Diffraction

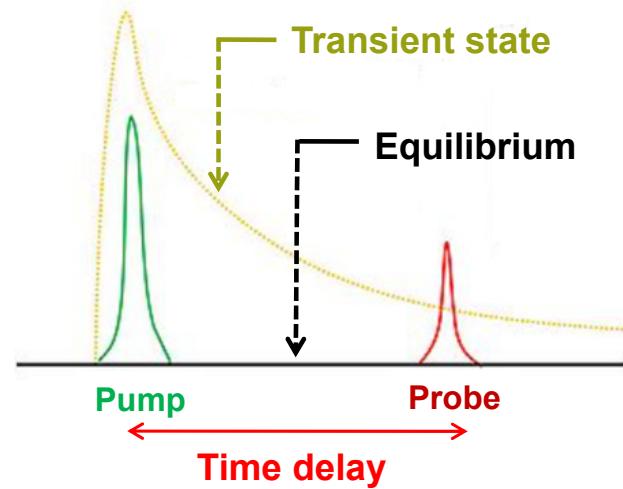
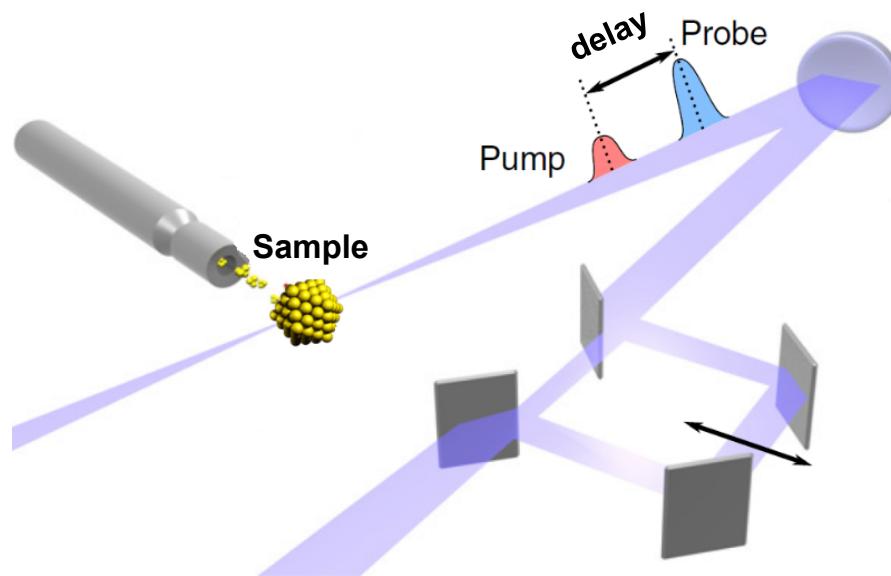


Crystallography



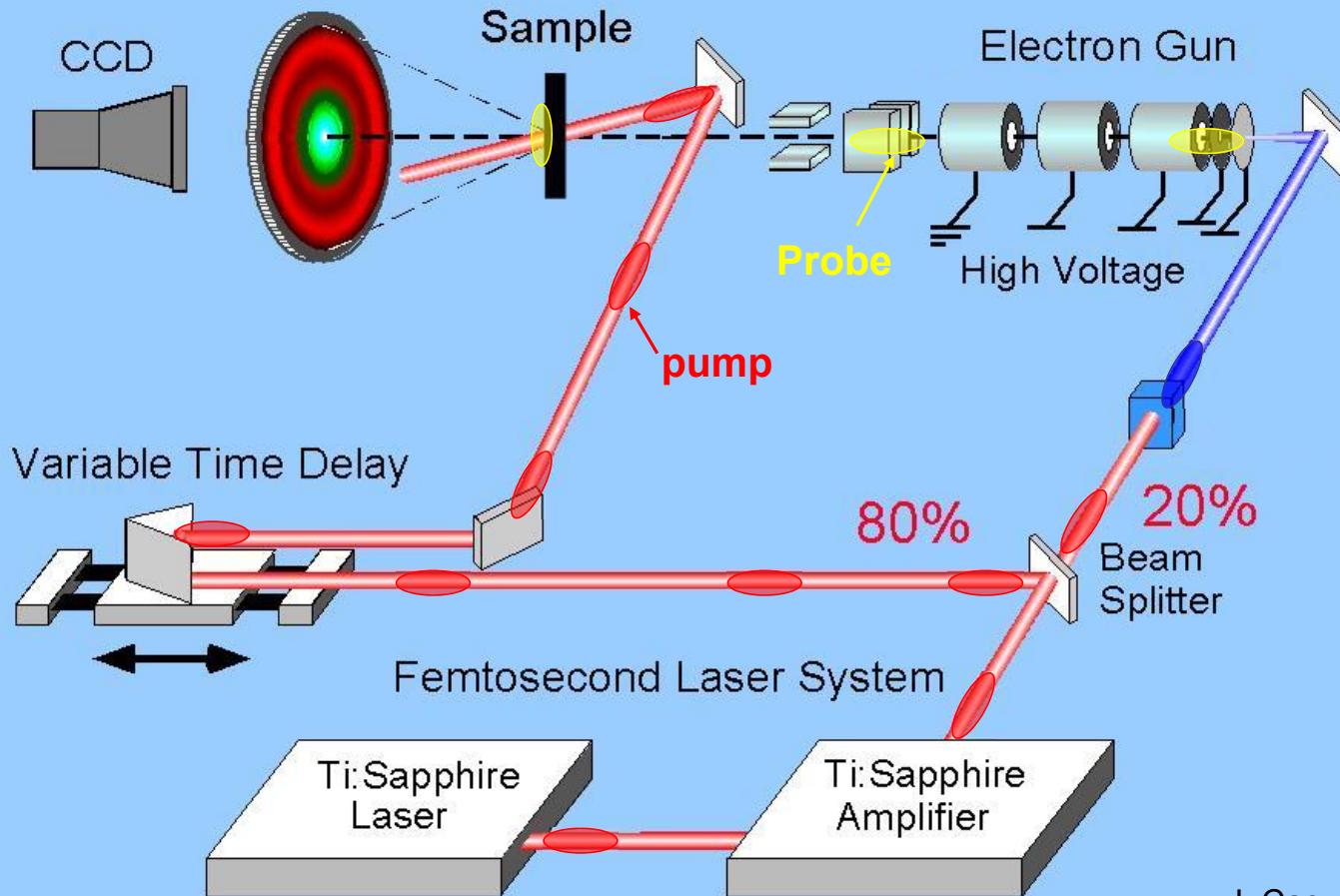
Coherent diffraction imaging

Temporal resolution: pump-probe technique

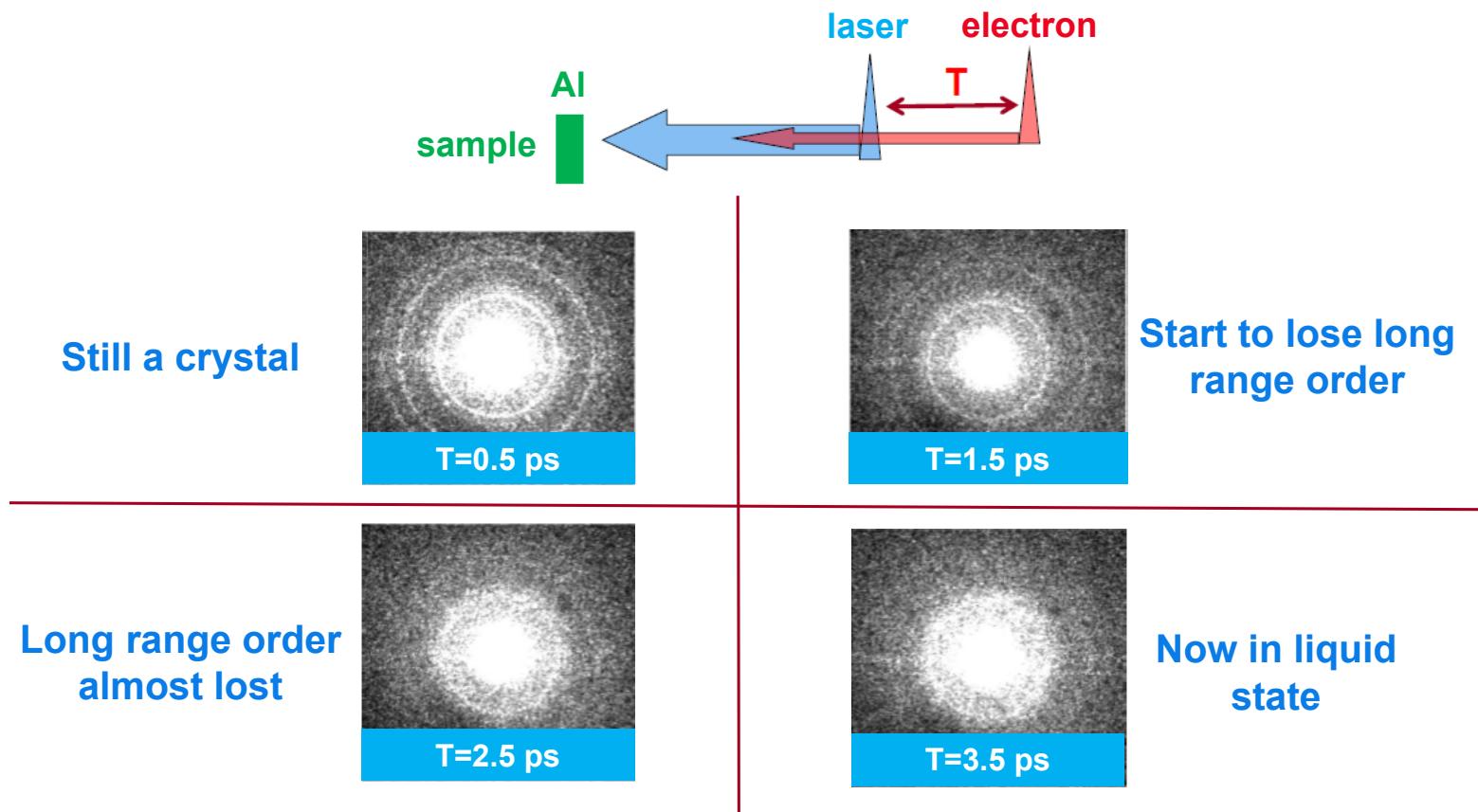


- A ‘pump’ pulse drives the system out of equilibrium state to initiate a dynamic process
- A ‘probe’ pulse measures the transient state following the excitation at a given delay time
- Changing time delay to map out the whole process by which the system relaxes back
- Pulsed x-ray or electron ‘probe’ beams provide both high spatial and temporal resolution
- Ultrafast Electron Diffraction (UED): laser-pump electron-probe technique

Ultrafast electron diffraction (UED): complementary to FELs



UED application: phase transition

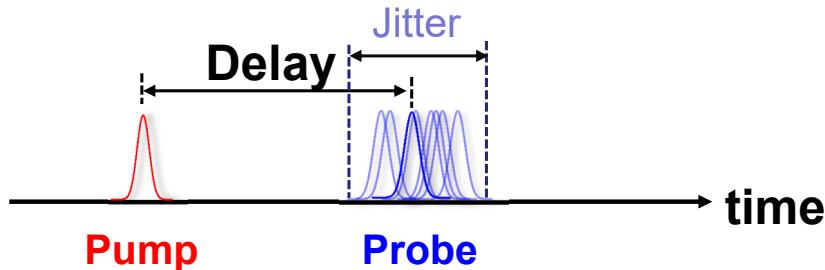


An atomic view of phase transition in Aluminium

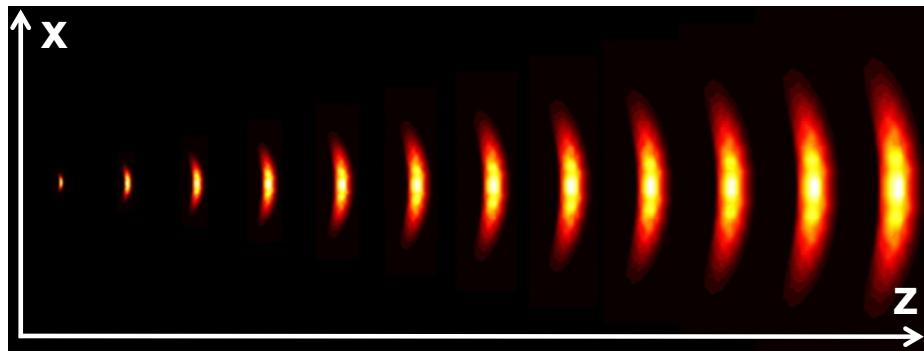
Science 302, 1382 (2003)

UED temporal resolution

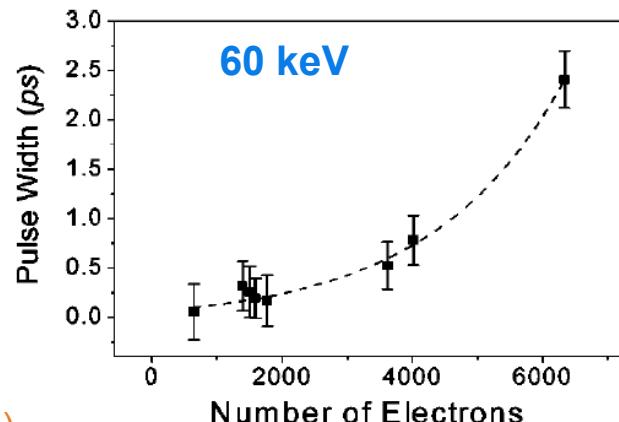
$$(\Delta t)^2 = (\Delta t_{laser})^2 + (\Delta t_e)^2 + (\Delta t_{jit})^2$$



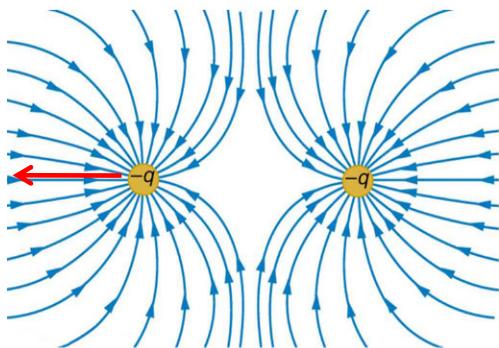
Electron beam pulse width limited by space charge effect



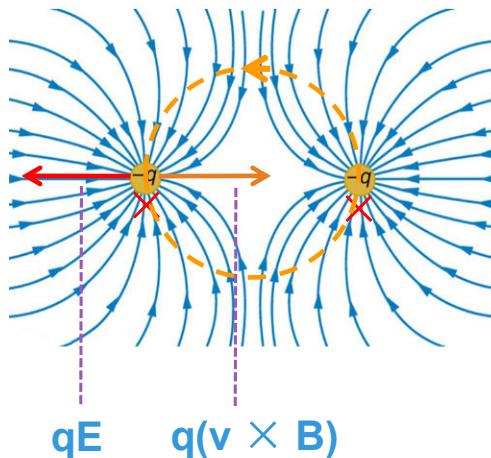
APL 83, 1044 (2003)



UED and UEM go relativistic



$$\mathbf{F} = q[\mathbf{E} + (\mathbf{v} \times \mathbf{B})]$$



- $v = 0.99c$ for 3 MeV electron beam
- The electric force and magnetic force largely cancel out
- MeV beam from a photocathode rf gun
- High acceleration gradient increases beam brightness
- High acceleration gradient reduces cost and size

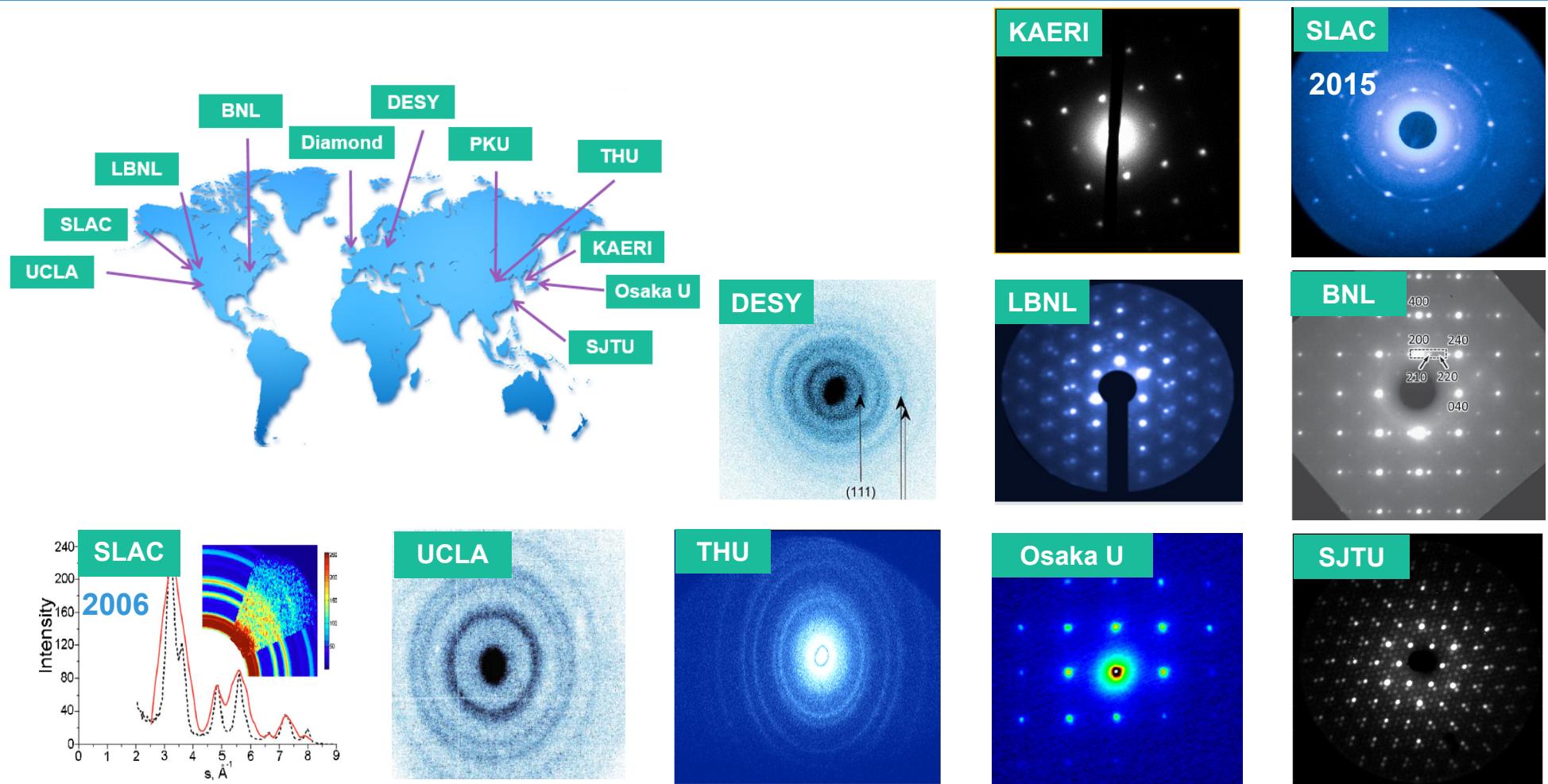
3 MeV TEM at Osaka



Outline

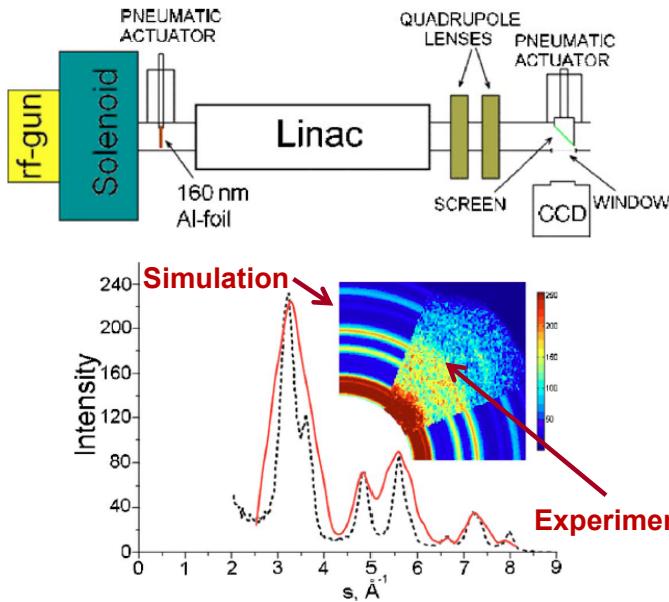
- **Introduction**
- **MeV UED and UEM developments**
- **Breaking ~50 fs resolution barrier**
- **Summary**

Accelerator-based MeV UED: world-wide efforts



Stage 1: proof-of-principle demonstration

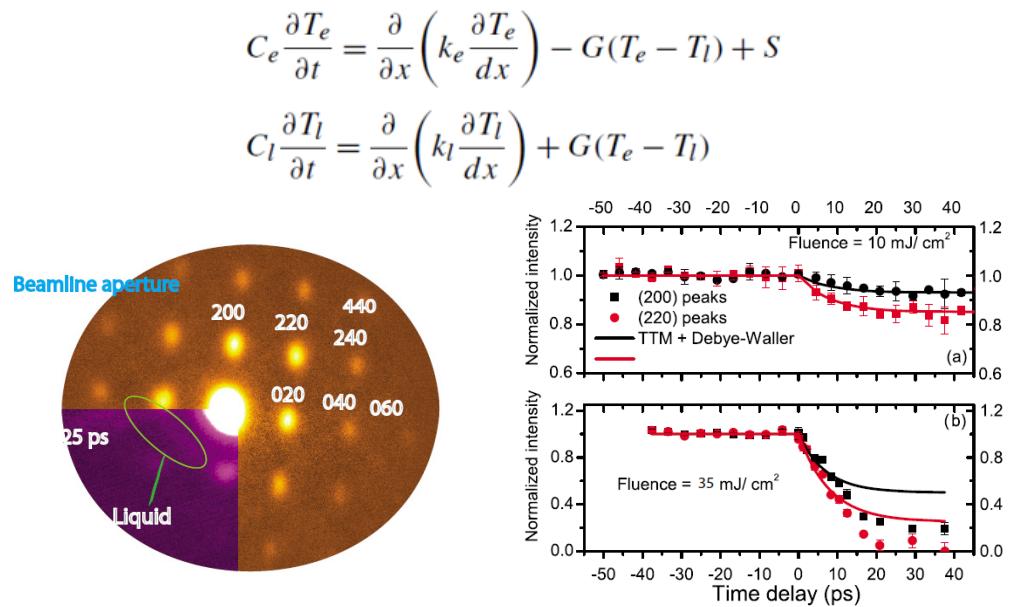
SLAC, 2006



- First demonstration of MeV UED
- Single-shot diffraction obtained with a 5.4 MeV / 3 pC / 500 fs beam
- No collimator to improve S/N ratio

APL 89, 184109 (2006)

UCLA, 2010

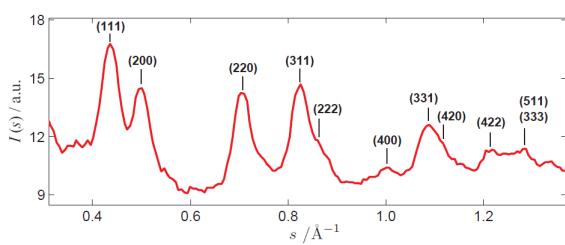
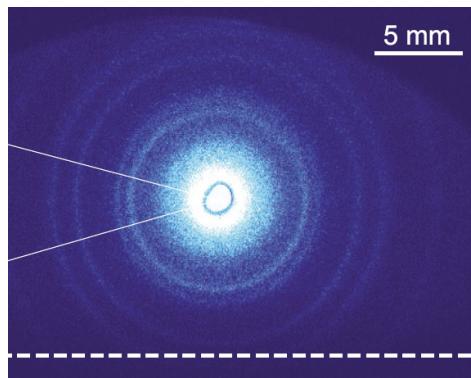


- For the first time MeV UED is used in a pump-probe experiment for studies of ultrafast dynamics
- Laser-induced Debye-Waller effect in Gold
- Collimator to improve S/N ratio

APL 97, 063502 (2010)

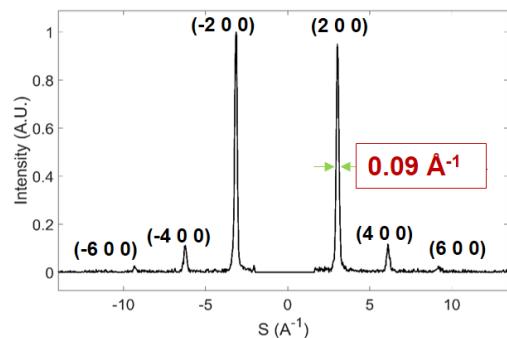
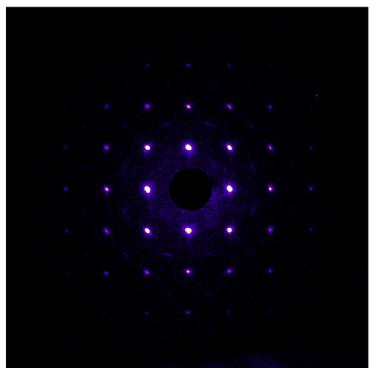
Stage 1: proof-of-principle demonstration

THU, 2009



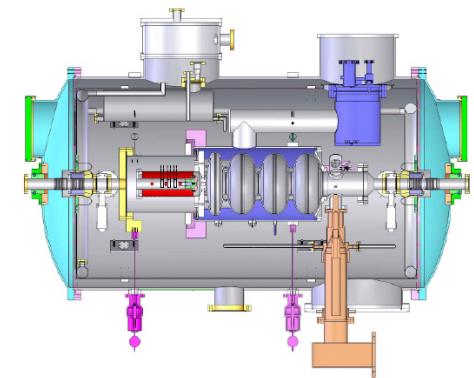
RSI 80, 083303 (2009)

SJTU, 2014

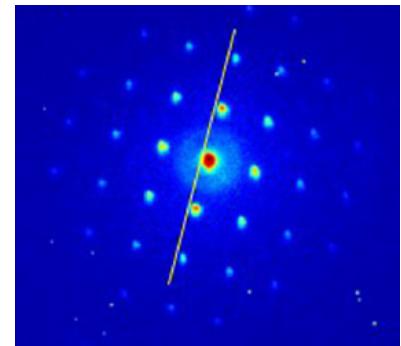


RSI 85, 083701 (2014)

PKU, 2015



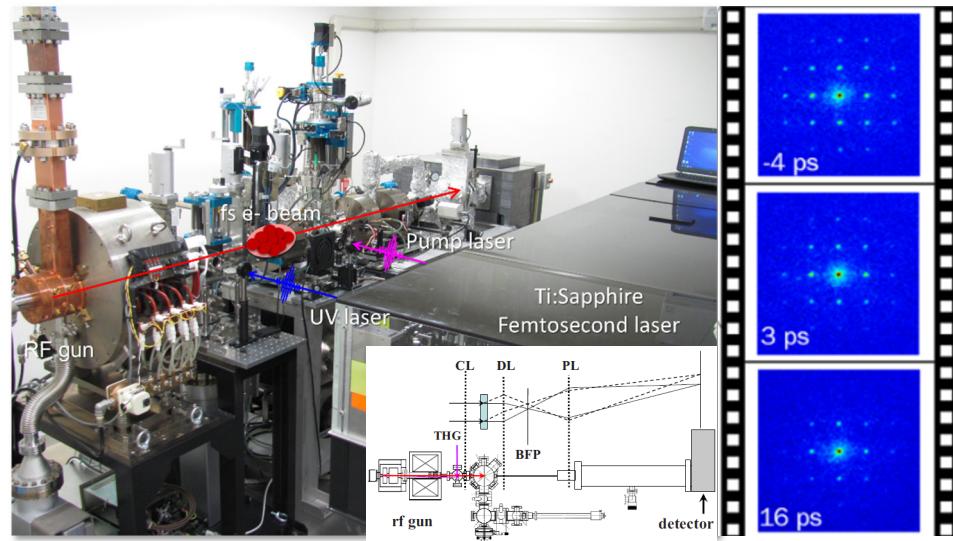
DC-SRF gun (\sim MHz)



APL 107, 224101 (2015)

Stage 1: proof-of-principle demonstration

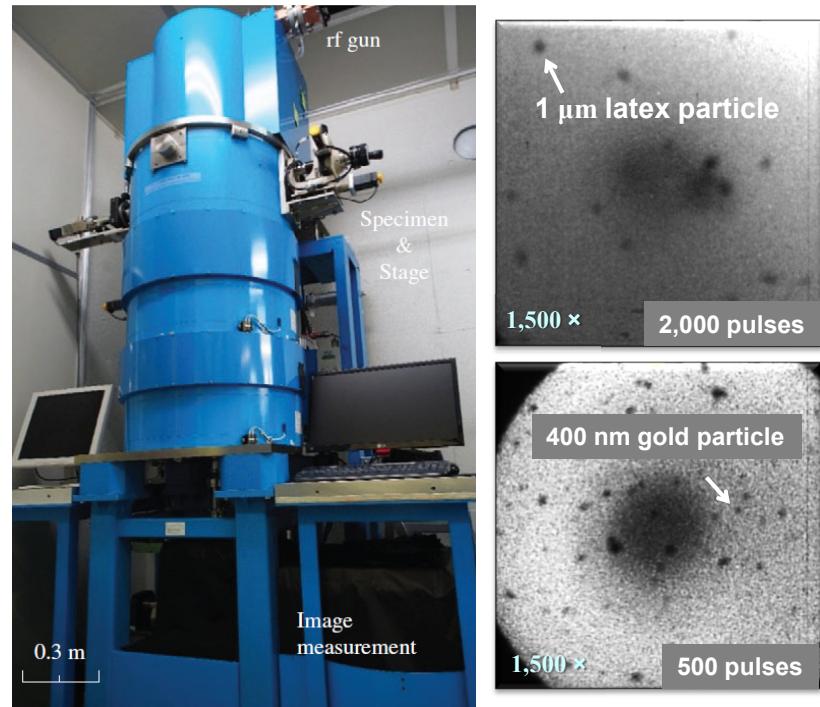
Osaka U, 2011



APL 98, 251903 (2011)

APL 103, 253107 (2013)

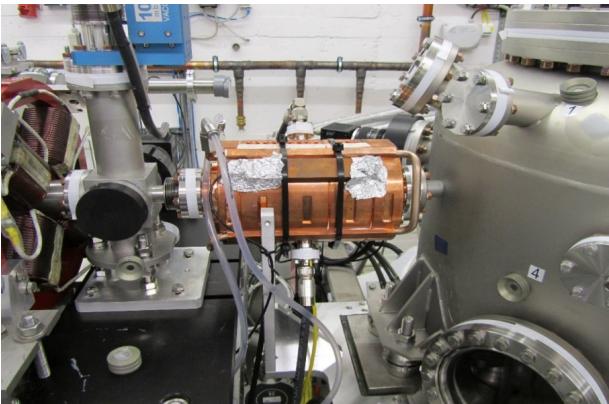
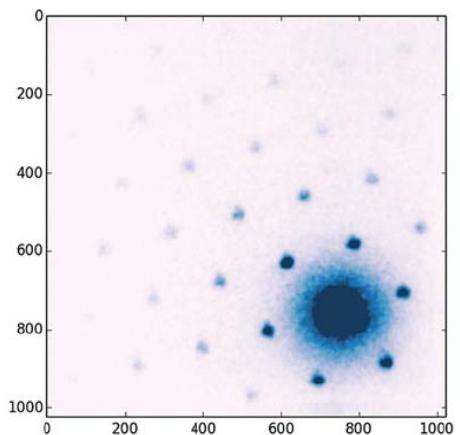
Microscopy 67, 291 (2018)



Ultrafast electron microscope

Stage 1: proof-of-principle demonstration

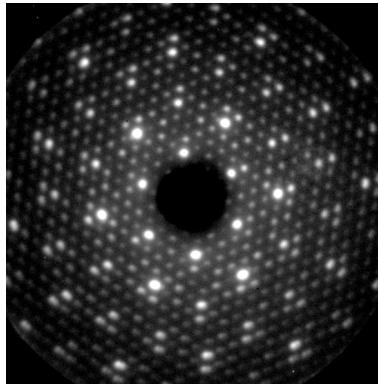
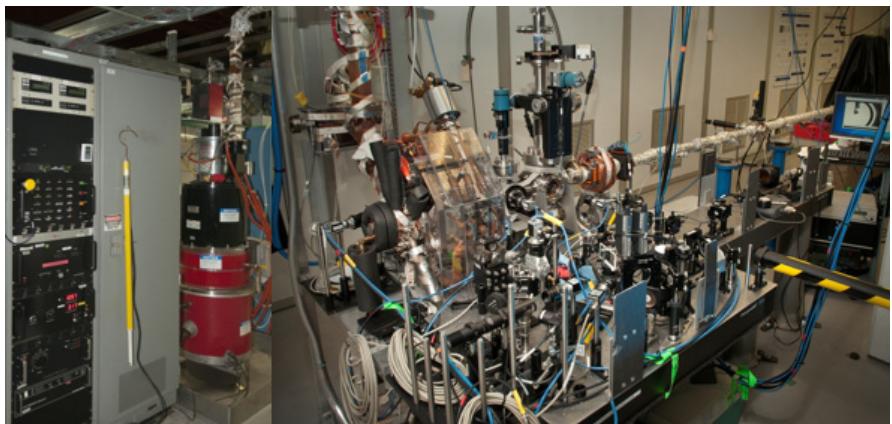
DESY/MPSD , 2015



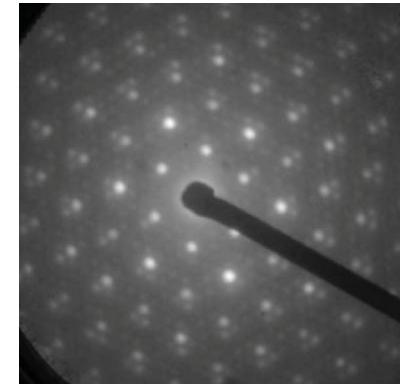
- **Static diffraction obtained**
- **Buncher and deflector to improve resolution**

Stage 2: from test facility to user facility

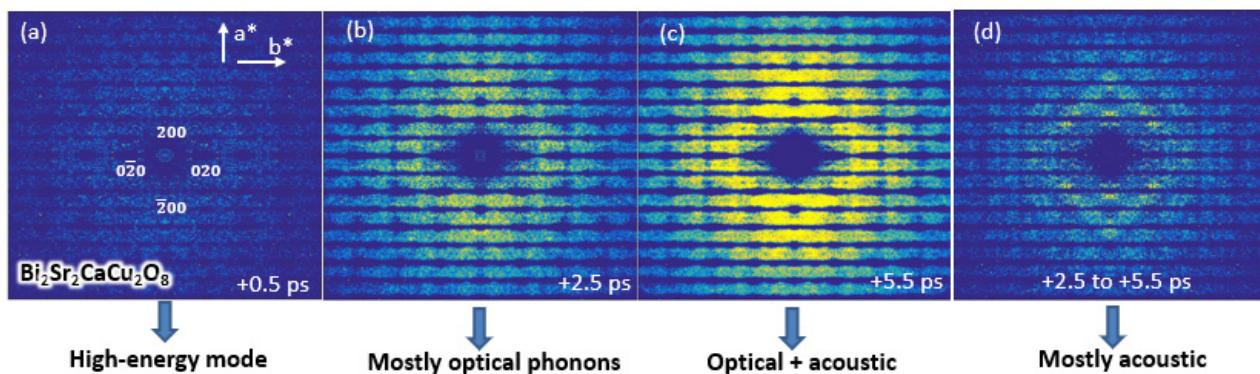
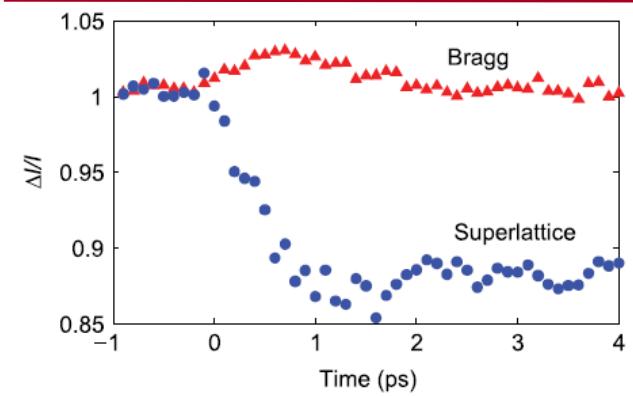
BNL



3 MeV UED

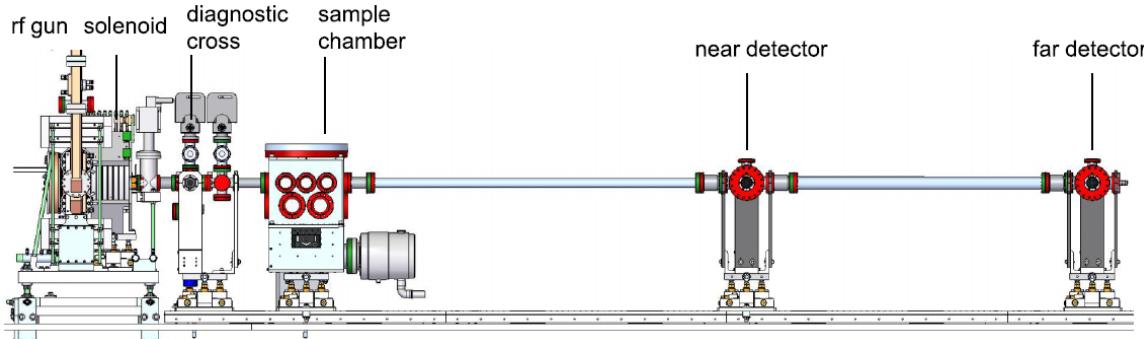


60 keV UED

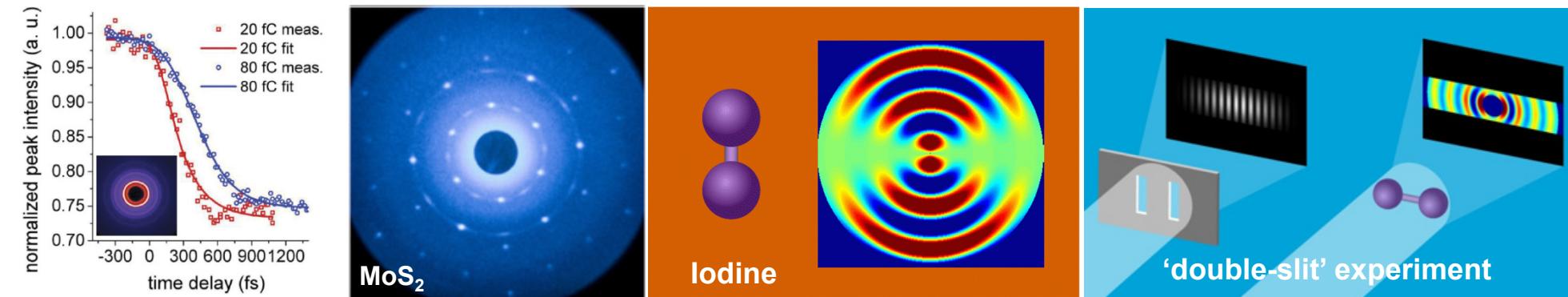


Stage 2: from test facility to user facility

SLAC



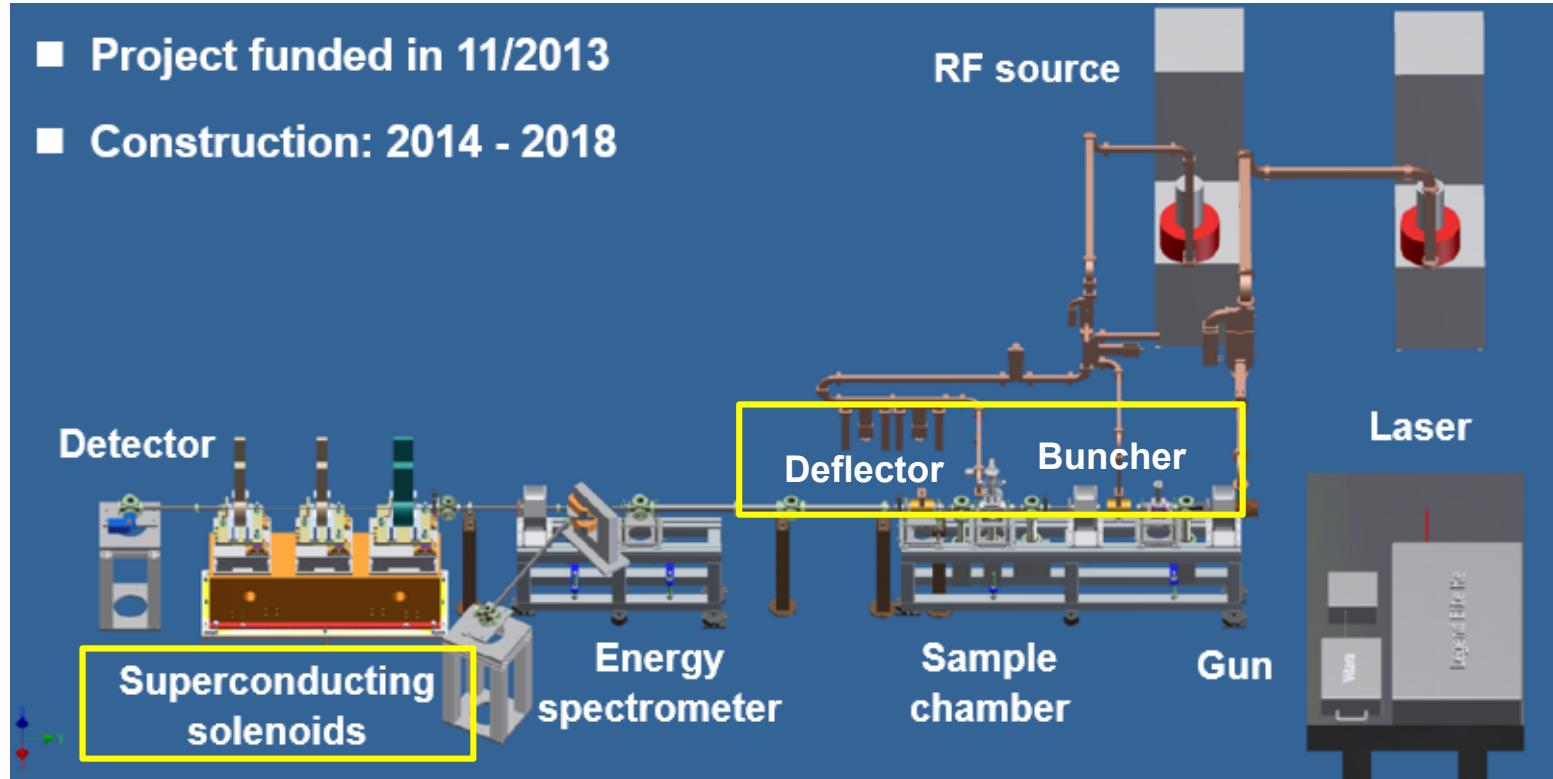
- State-of-the-art
- 180 Hz / 150 fs resolution (FWHM)
- Optical to THz pump pulse
- Solid / gas sample
- 30 K – 400 K temperature control
- 5-axis sample manipulation
- Now a DOE user facility



Stage 2: from test facility to user facility

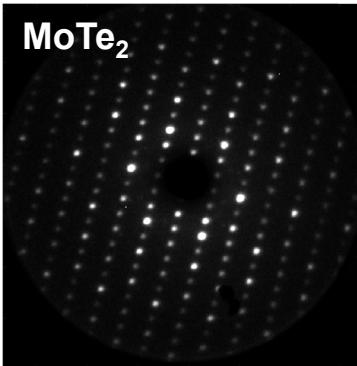
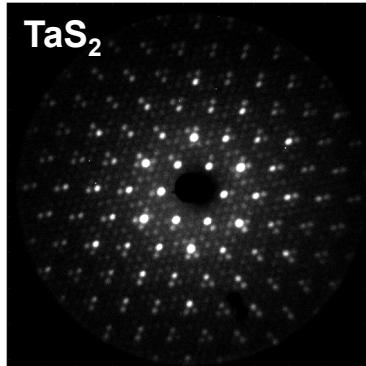
SJTU

- Project funded in 11/2013
- Construction: 2014 - 2018

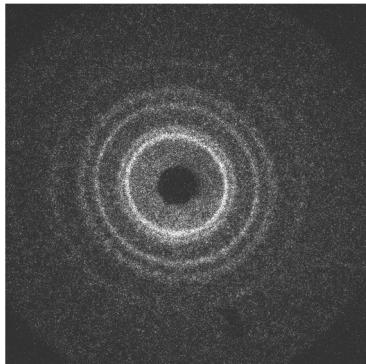


3 MeV ultrafast electron diffraction and microscope

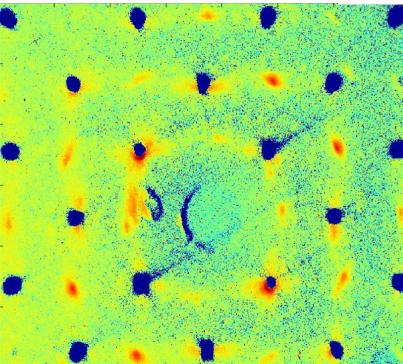
Stage 2: from test facility to user facility



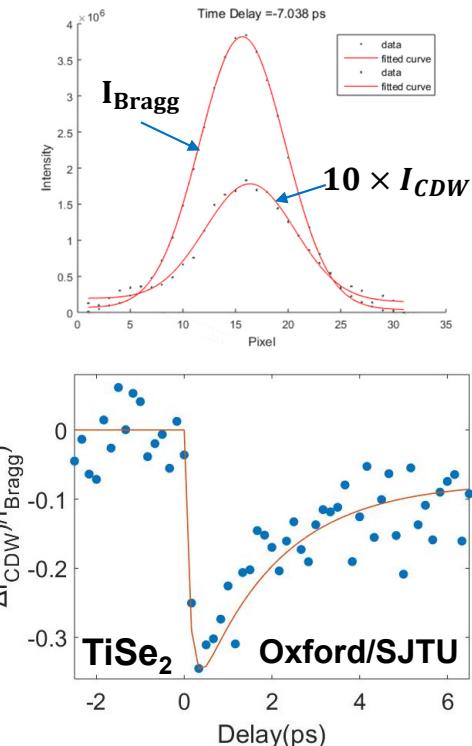
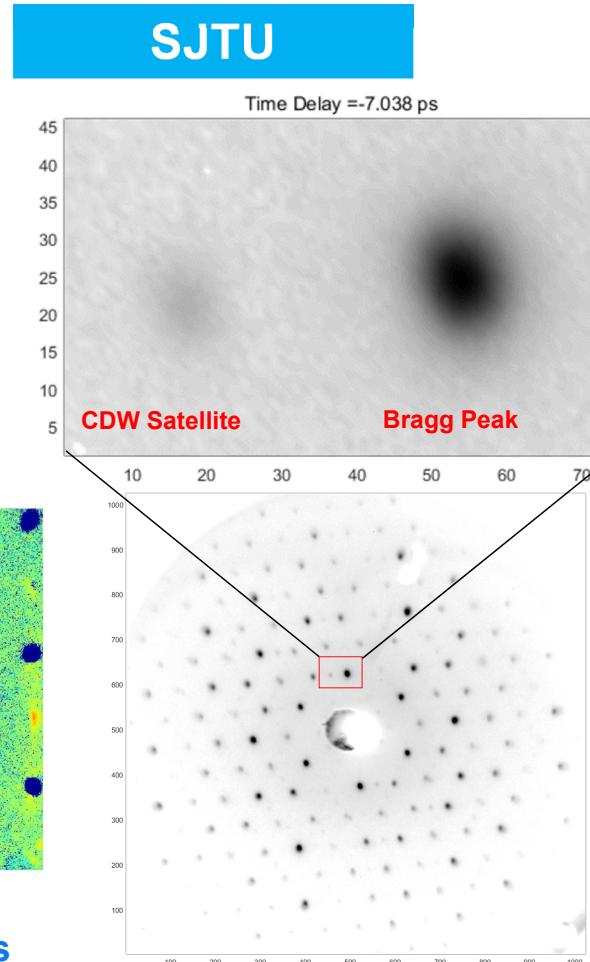
High quality electron diffraction



Single-shot with
 ~ 100 fs beam

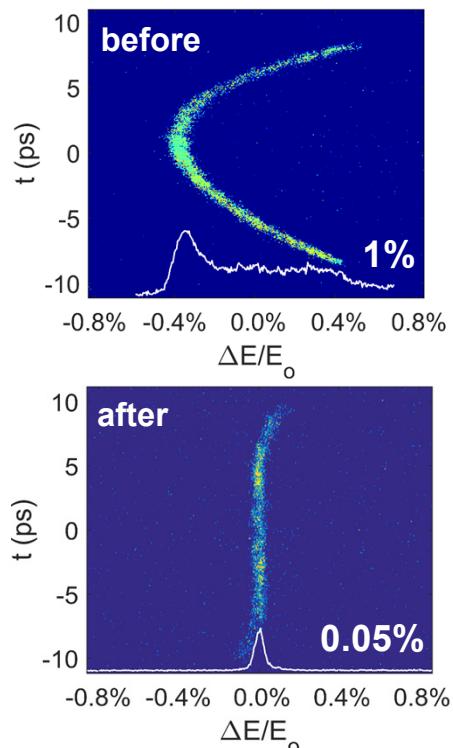
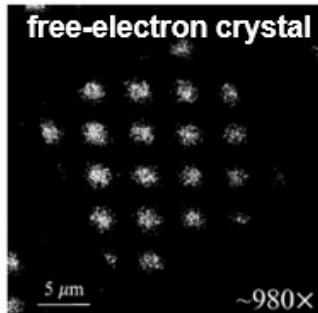
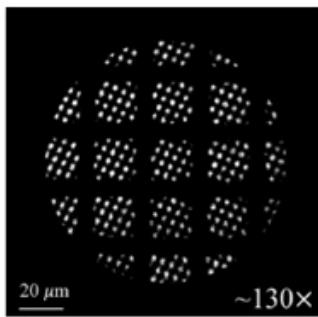
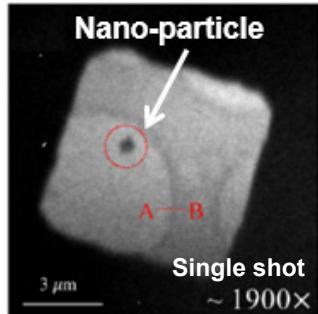


Diffuse scattering
with $\sim 10^{10}$ electrons



Charge density wave dynamics
Manuscript in preparation

Stage 2: from test facility to user facility

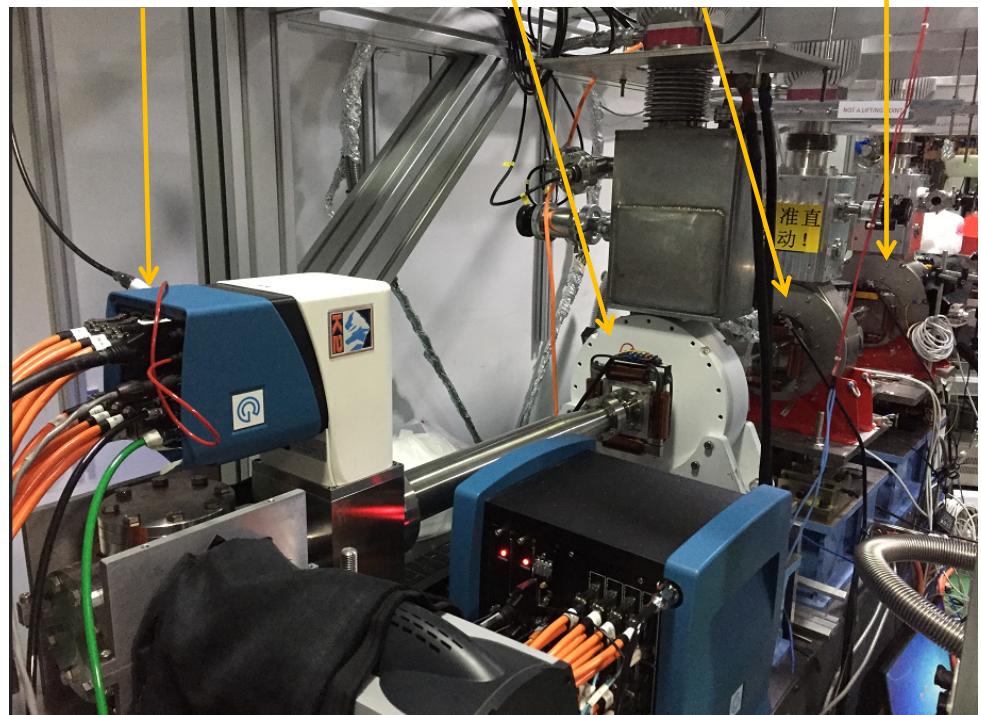


SJTU

Gatan K2
camera

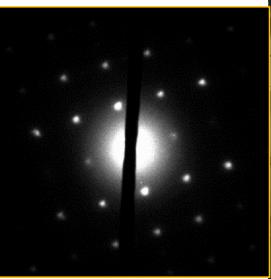
projection
lens

objective
lens



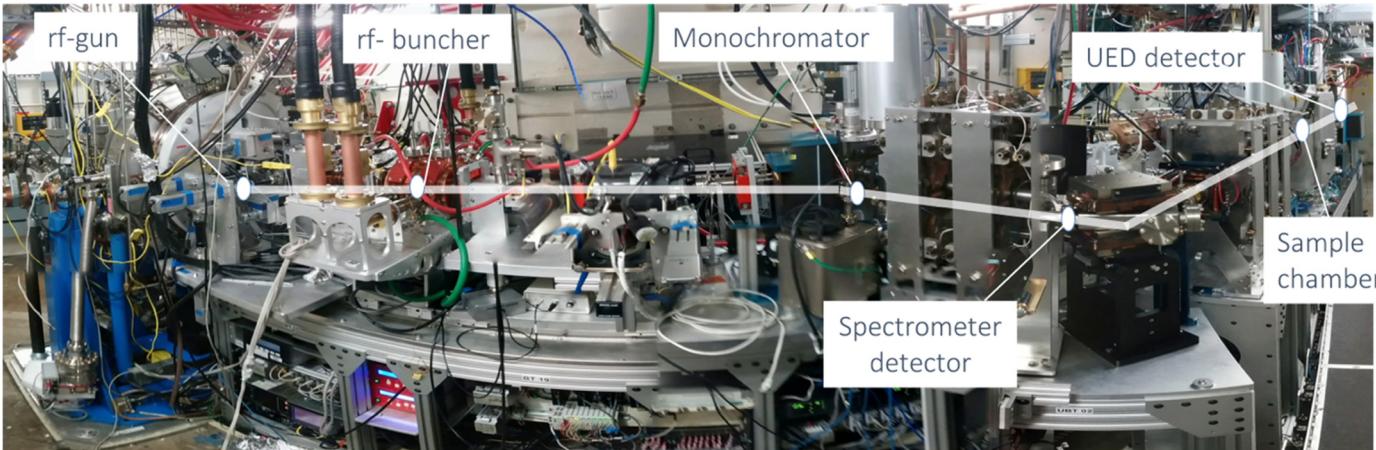
Stage 2: from test facility to user facility

KAERI



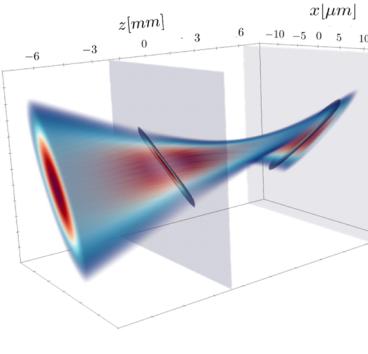
Stage 2: from test facility to user facility

LBNL: High Repetition Rate Electron Scattering beamline (HiRES)

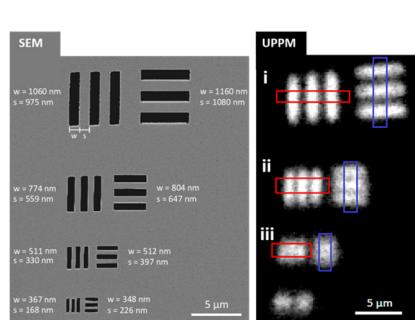


Electron beam energy	700-900 keV
Repetition rate	1-10 ⁶ Hz
Temporal resolution	200 fs-1000 ps
Electrons per pulse	1-10 ⁸
Relative energy spread	10 ⁻³ 10 ⁻⁴

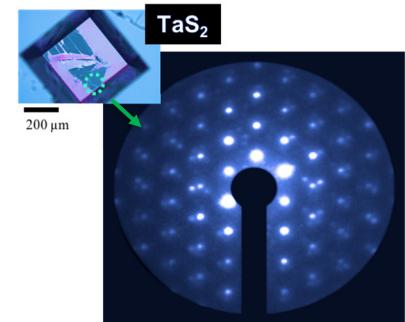
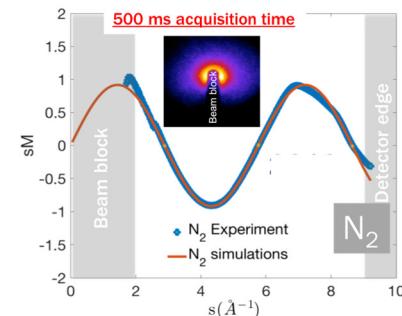
Nano-UED and UPPM



arXiv:1901.03443
arXiv:1903.12610



Gas and solid state experiments ongoing



Outline

- **Introduction**
- **MeV UED and UEM developments**
- **Breaking ~50 fs resolution barrier**
- **Summary**

break ~50 fs resolution barrier

$$(\Delta t)^2 = (\Delta t_{laser})^2 + (\Delta t_e)^2 + (\Delta t_{jit})^2$$

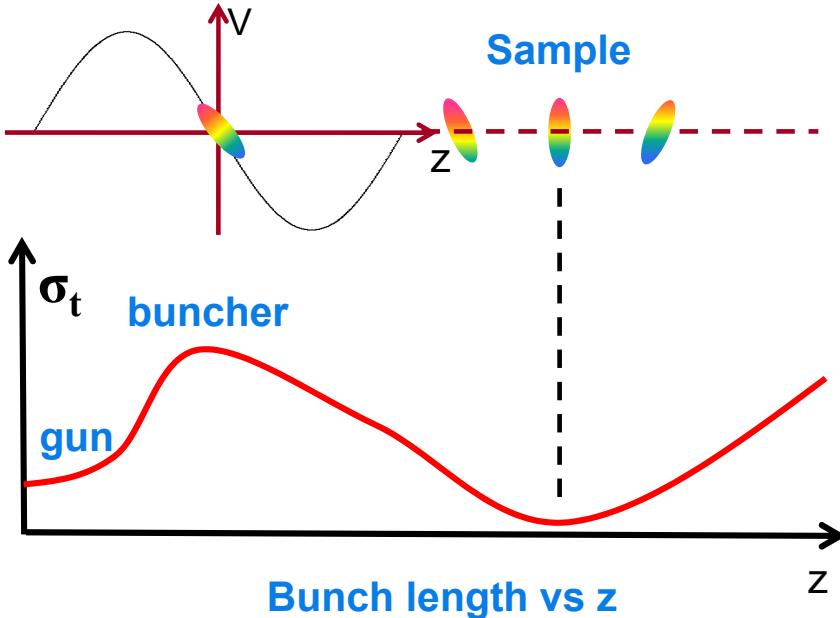
- **rf compression + time stamping**

Produce short beam and correct timing jitter

- **Compression with space charge force**

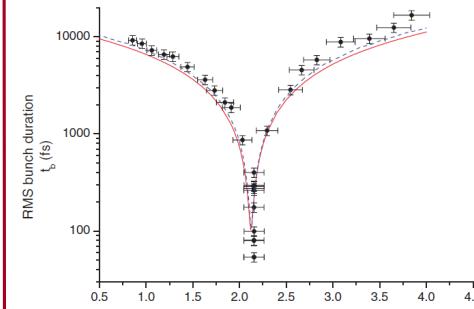
Produce short beam with small timing jitter

rf compression + time stamping



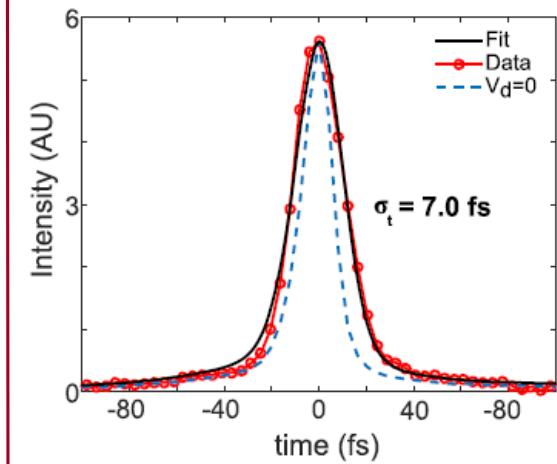
- Negative energy chirp
- Low energy electrons slow down
- High energy electrons catch up

95 keV beam
10 ps \rightarrow 100 fs



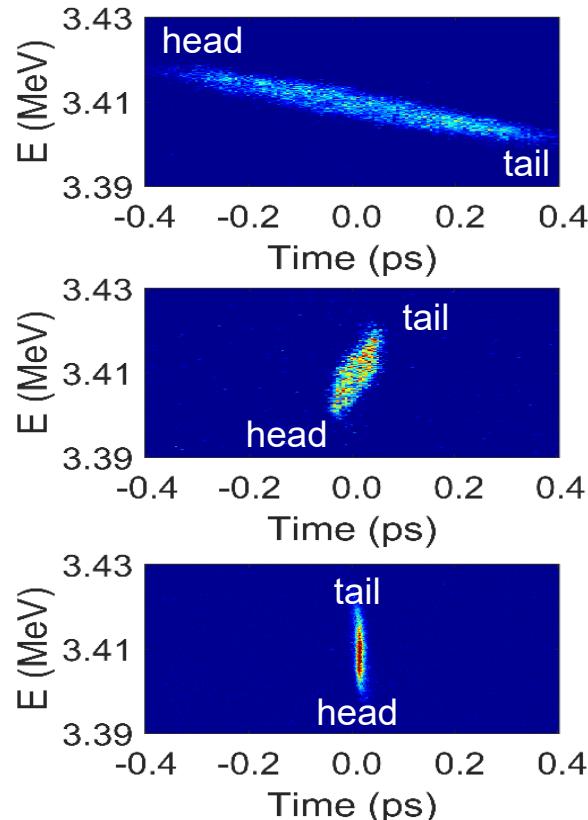
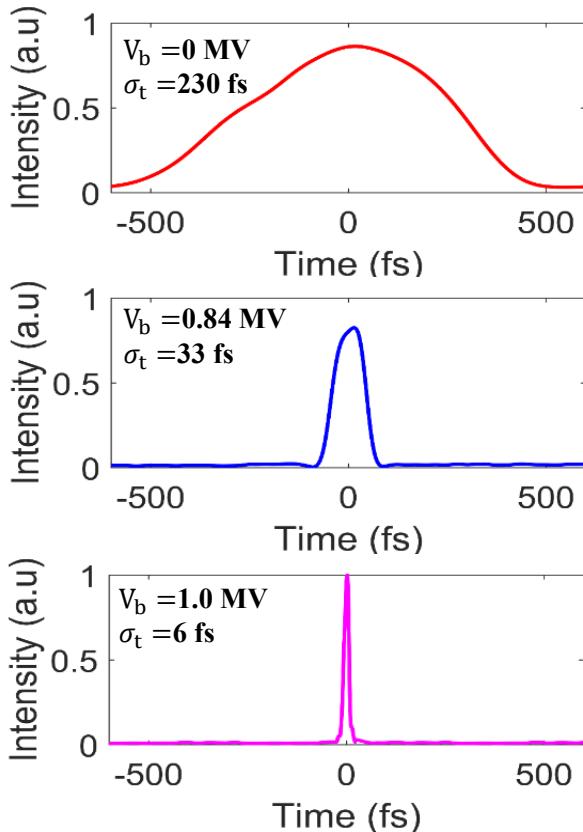
PRL 105, 264801 (2010)

UCLA, 5 MeV
~100 fs \rightarrow ~7 fs



- X-band buncher
 - X-band deflector (400 kV)
- PRL 118, 154802 (2017)

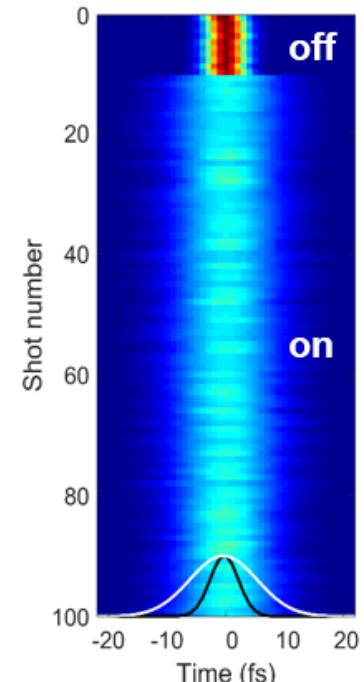
rf compression + time stamping



Bunch length and longitudinal phase space

PRX 8, 021061 (2018)

SJTU, 3 MeV
~200 fs → 6 fs



- C-band buncher
- C-band deflector (2 MV)

rf compression + time stamping

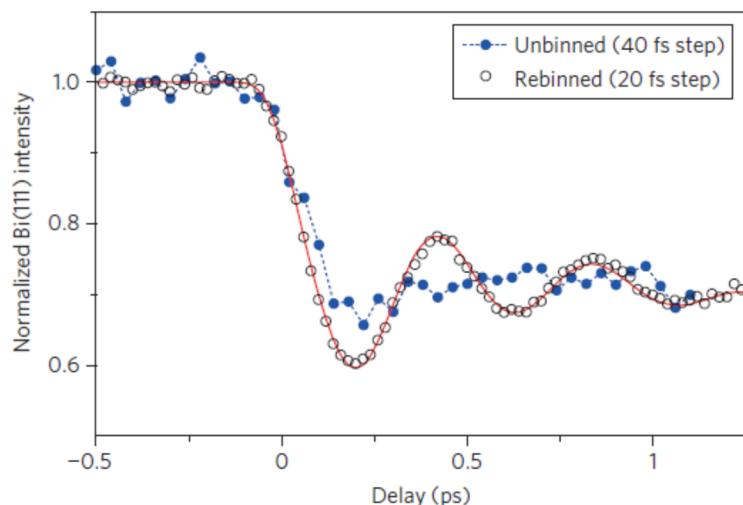
Measure and sort

nature
photronics

LETTERS

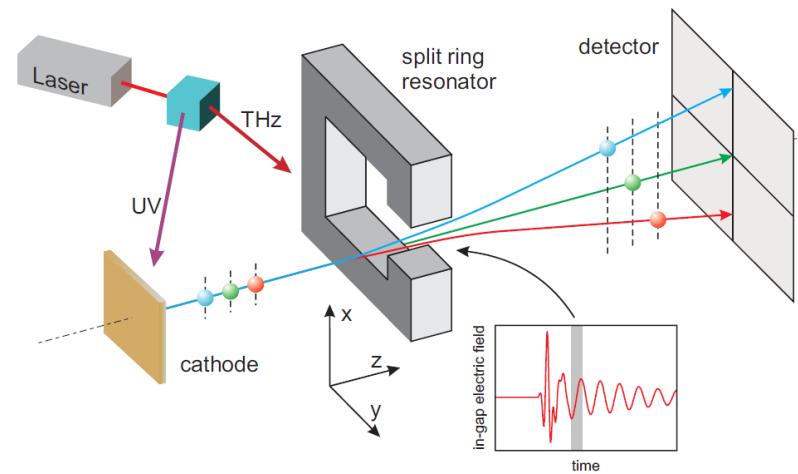
PUBLISHED ONLINE: 17 FEBRUARY 2013 | DOI: 10.1038/NPHOTON.2013.11

Achieving few-femtosecond time-sorting at hard X-ray free-electron lasers



7 papers published in Nature Photonics

THz deflector

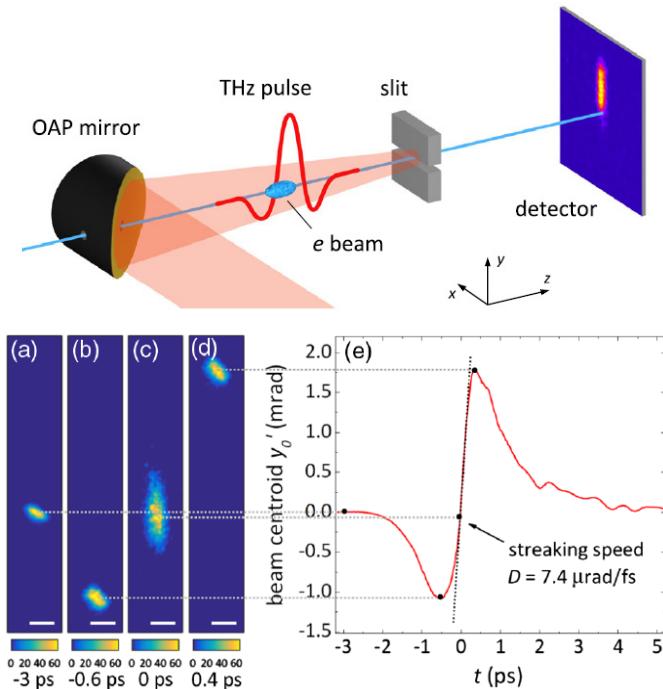


- THz pulse in tight synchronization with laser
- Time-dependent angular kick
- E-field is not in phase with B-field in the gap
- Field enhancement in the narrow gap

Sci Rep 4, 5645 (2014)

rf compression + time stamping

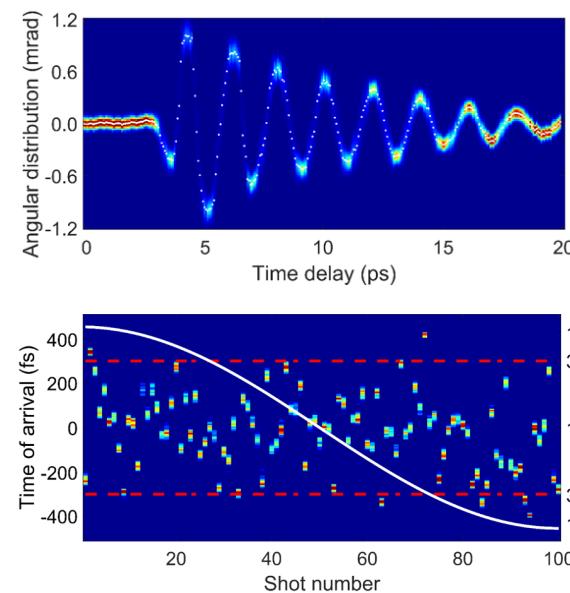
THz streaking at SLAC



- 4 mm X 50 μm slit
- Single oscillation

PRAB 22, 012803 (2019)

THz streaking at SJTU



Time stamping of a 6 fs beam

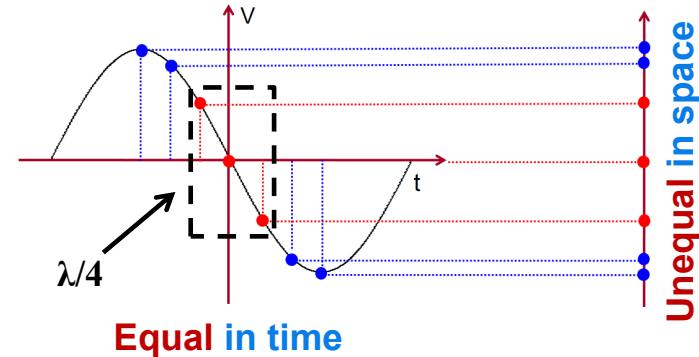
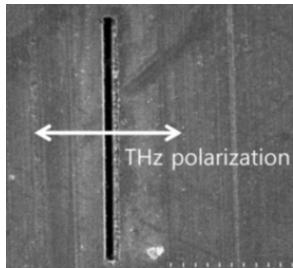
- 250 μm X 10 μm slit
- multipole oscillation
- 6 fs beam with jitter corrected with 1.5 fs accuracy

PRX 8, 021061 (2018)

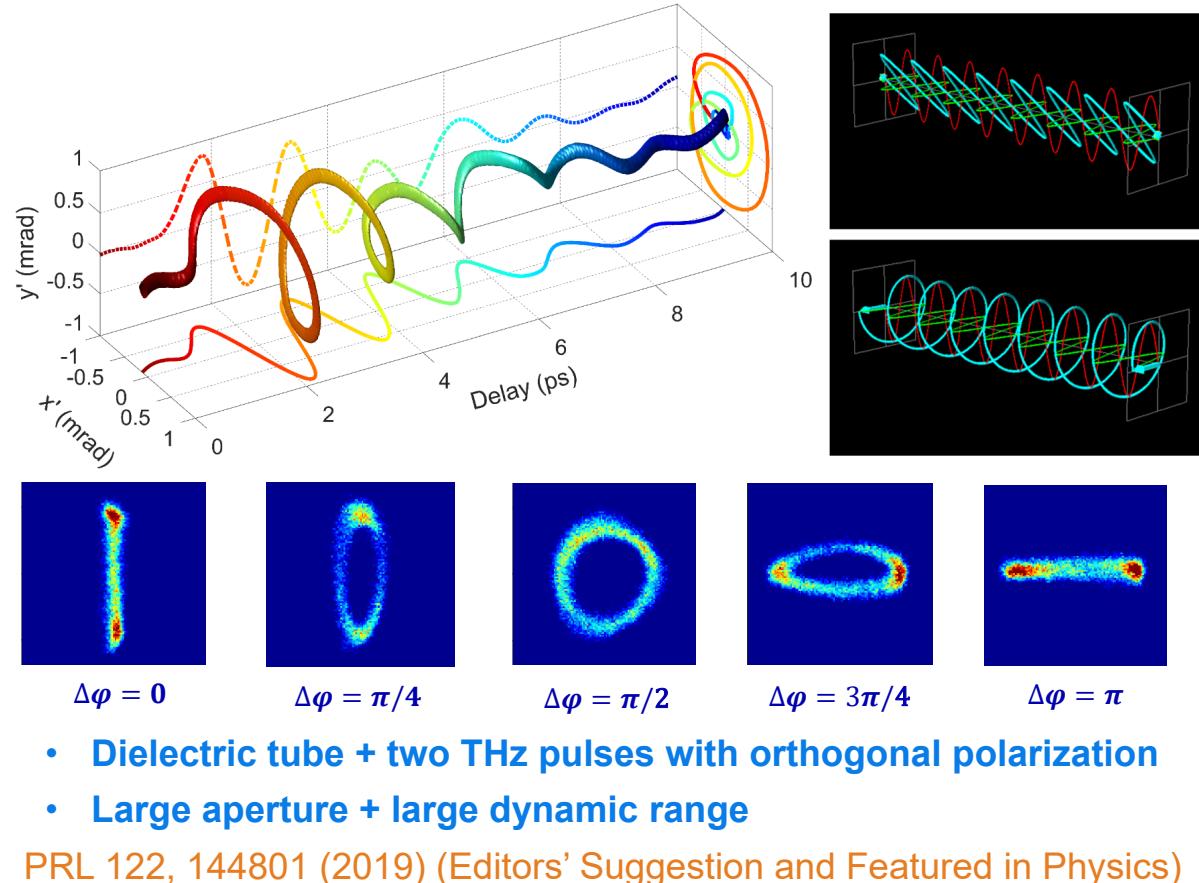
Deflection vs time delay

rf compression + time stamping

THz oscilloscope for recording time information



- Small aperture
- Limited dynamic range



break ~50 fs resolution barrier

$$(\Delta t)^2 = (\Delta t_{laser})^2 + (\Delta t_e)^2 + (\Delta t_{jit})^2$$

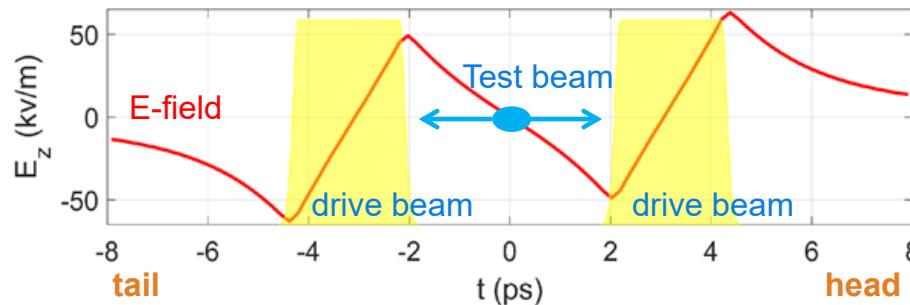
- **rf compression + time stamping**

Produce short beam and correct timing jitter

- **Compression with space charge force**

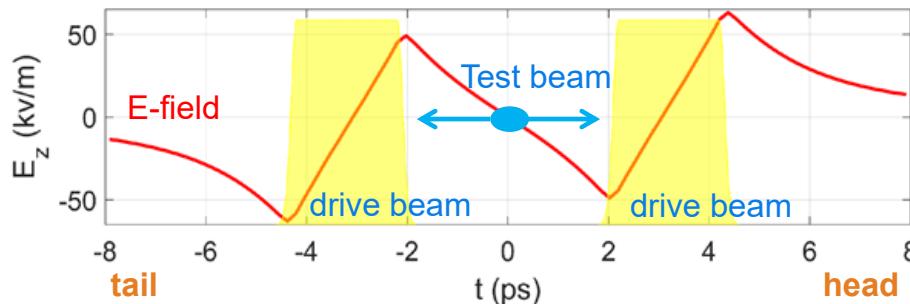
Produce short beam with small timing jitter

Compression with space charge force

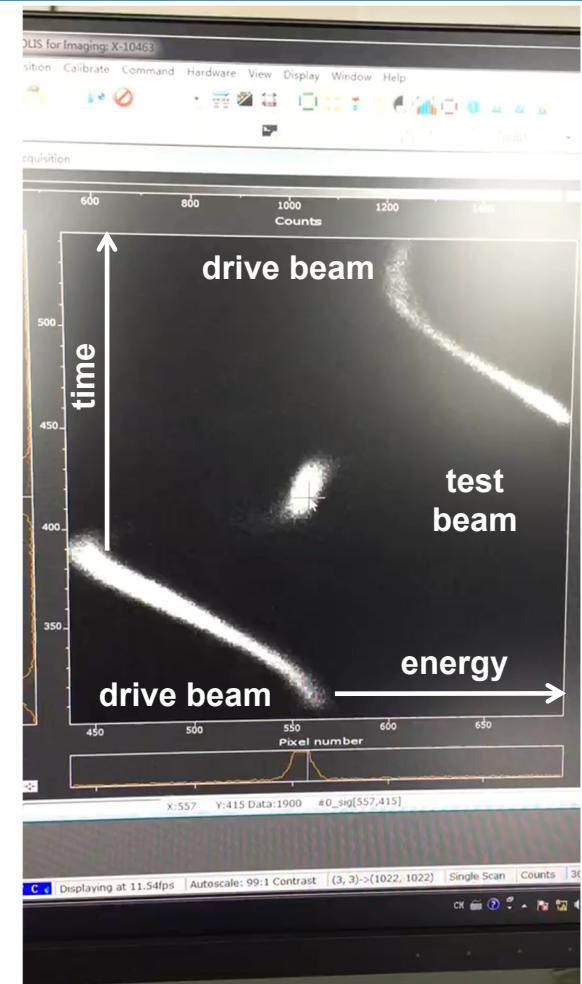


- Test beam in the middle of two drive beams
 - Negative energy chirp
 - Centroid energy will not change
 - Test beam will be compressed with negligible timing jitter
-
- The front drive beam pushes the test beam backward
 - The back drive beam pushes the test beam forward
 - The test beam stays in the middle with its pulse width reduced

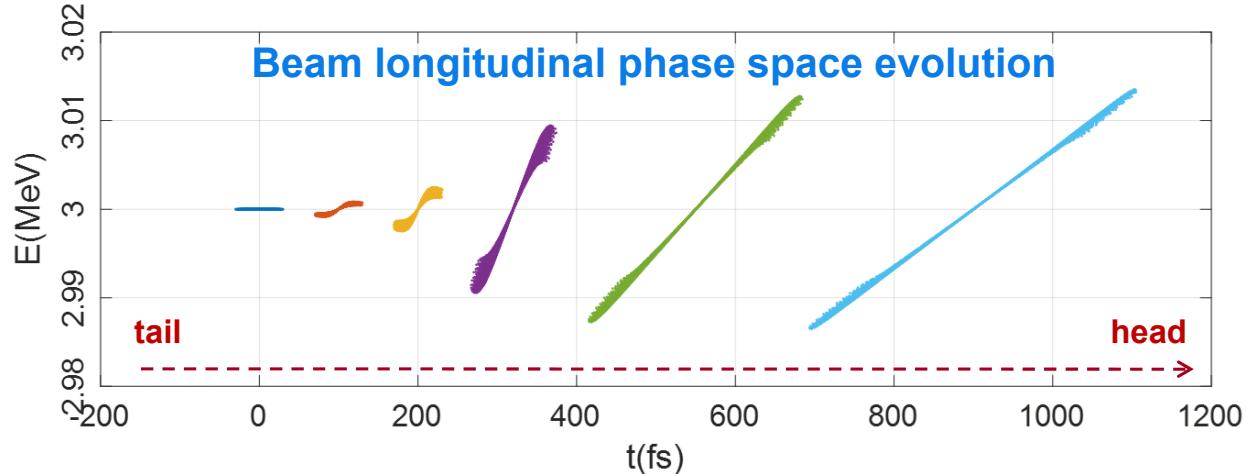
Compression with space charge force



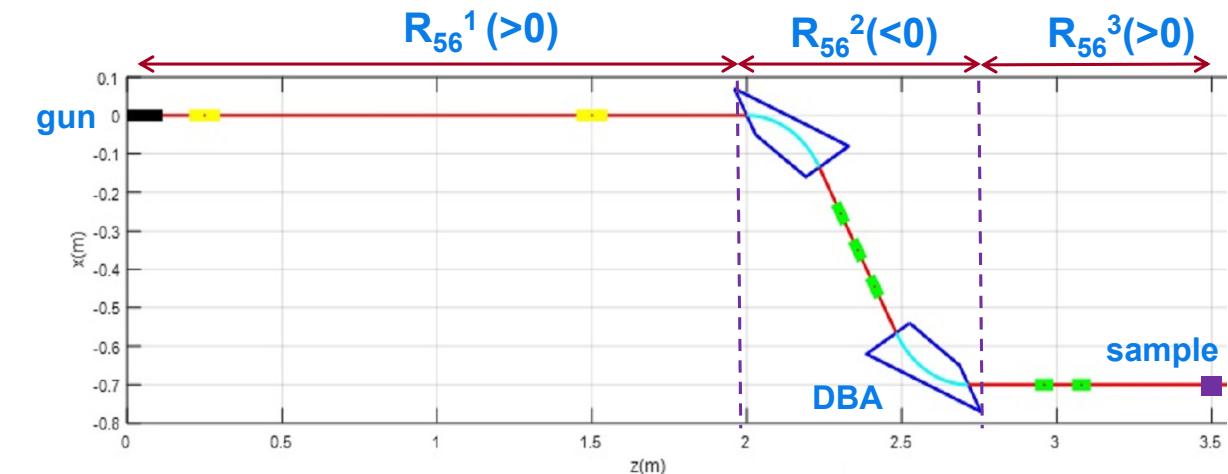
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 - The back drive beam pushes the test beam forward
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Compression with a double-bend achromat (DBA)



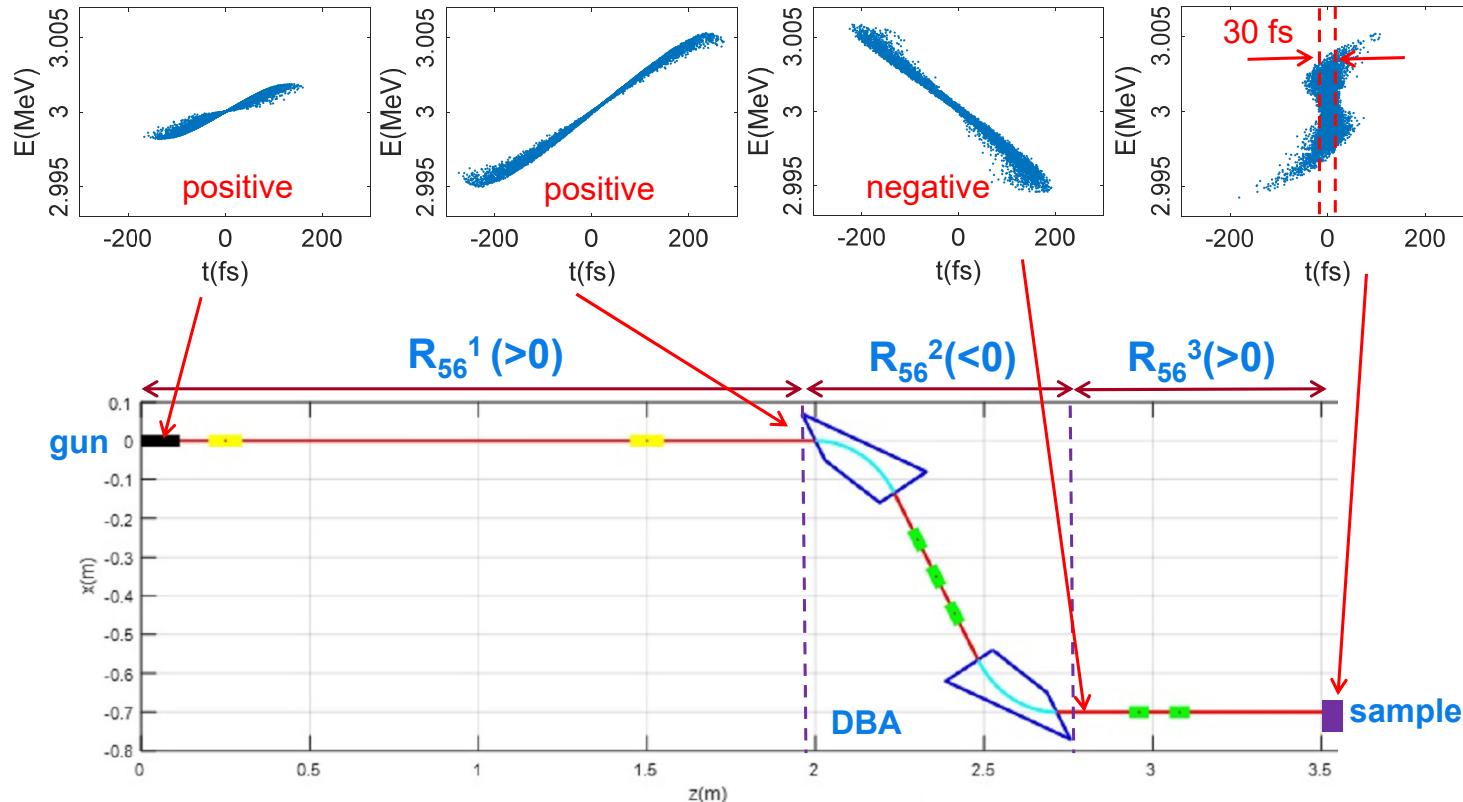
Space charge force induces positive energy chirp without changing beam centroid energy



- Isochronous: $R_{56}^{-1} + R_{56}^{-2} + R_{56}^{-3} = 0$
 - Gun amplitude jitter won't convert to arrival timing jitter
 - Space charge induced positive energy chirp leads to bunch compression ($R_{56}^{-2} + R_{56}^{-3} < 0$)
 - Jitter free bunch compression

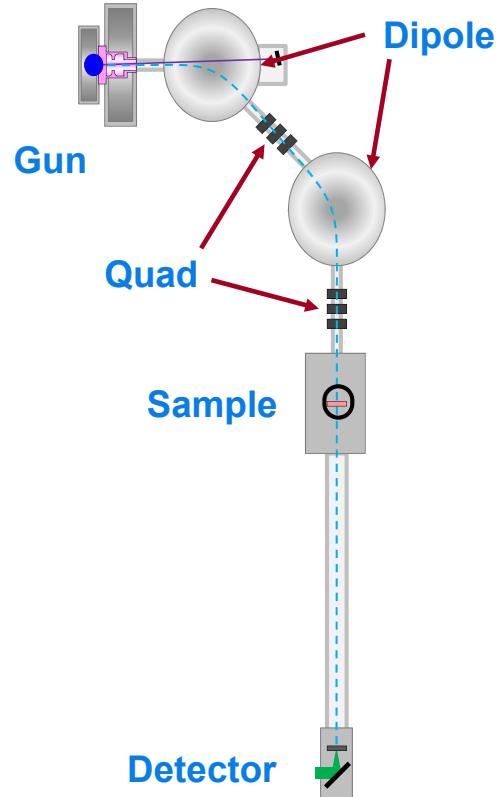
Compression with a double-bend achromat (DBA)

~30 fC beam compressed to ~30 fs (FWHM) with <5 fs timing jitter

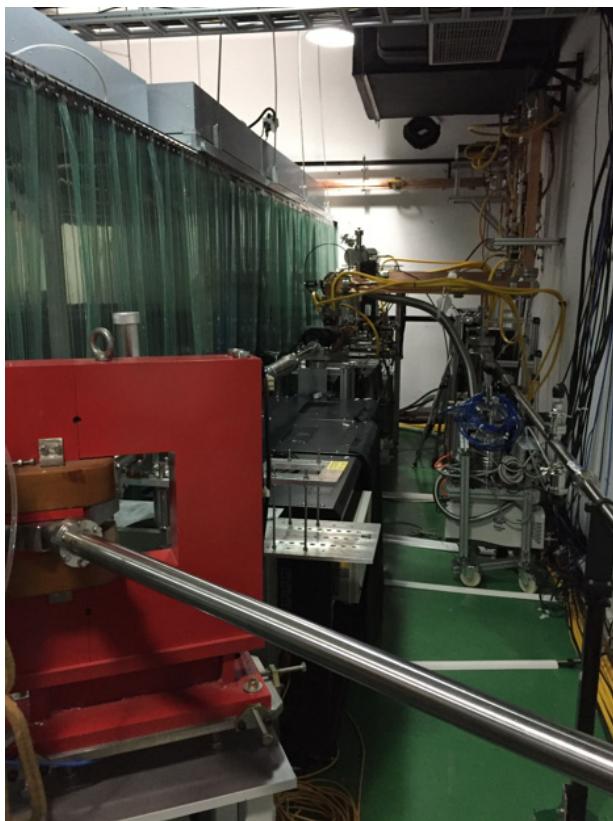


Compression with a double-bend achromat (DBA)

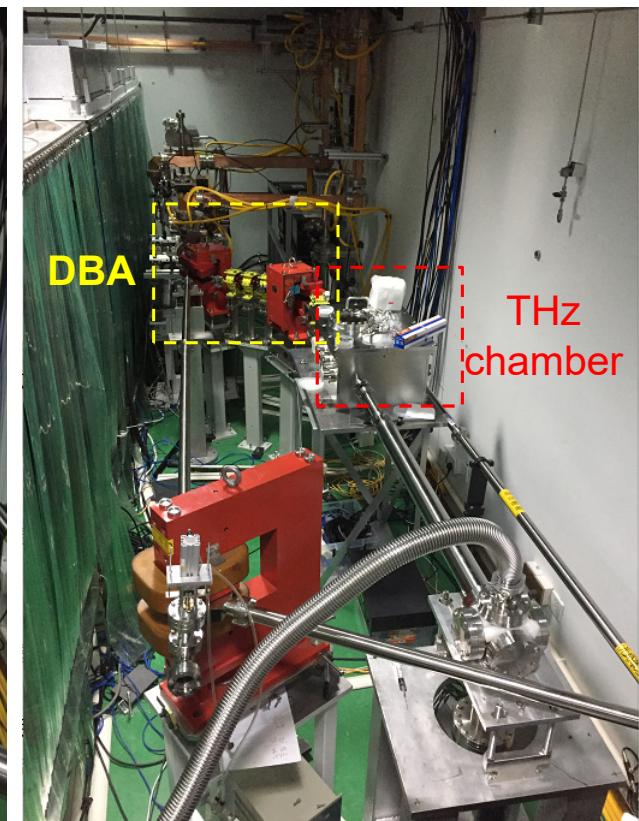
KAERI



SJTU

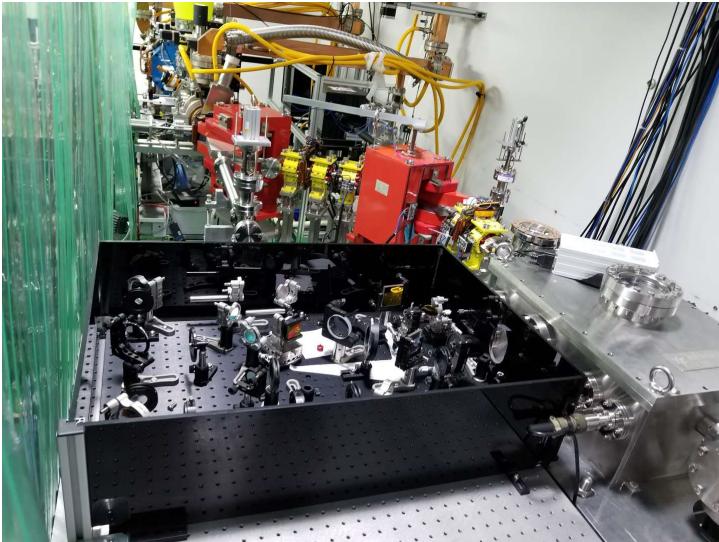


Before installation

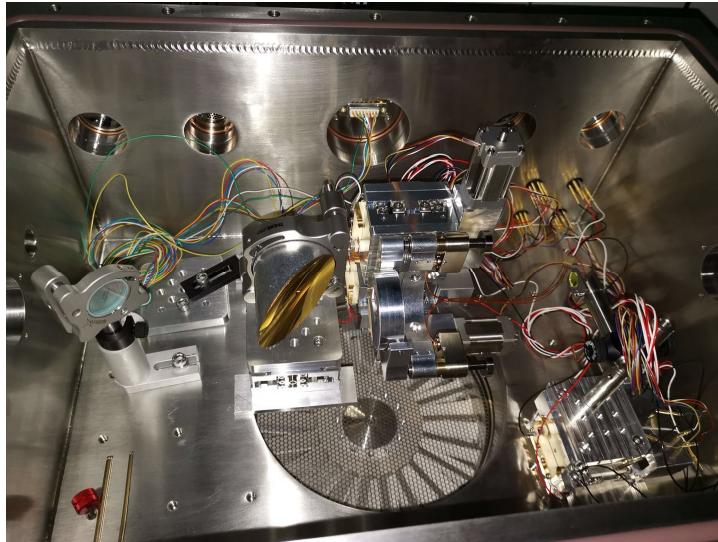


New DBA beamline

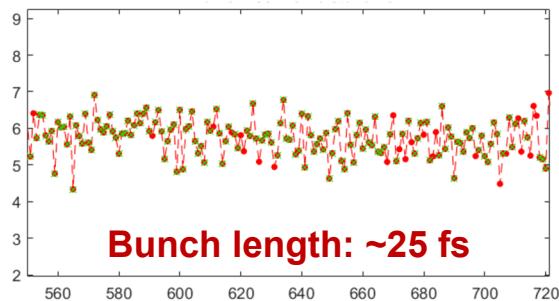
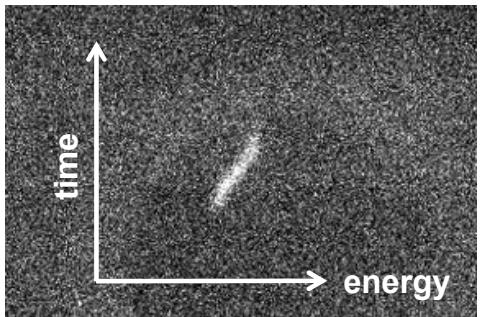
Compression with a double-bend achromat (DBA)



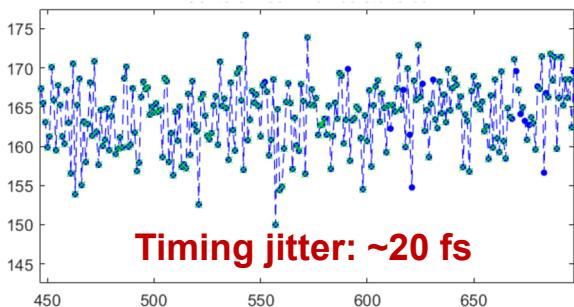
THz source for measuring electron bunch length and jitter



THz-electron interaction chamber



Bunch length: ~25 fs



Timing jitter: ~20 fs

Outline

- **Introduction**
- **MeV UED and UEM developments**
- **Breaking ~50 fs resolution barrier**
- **Summary**

Summary

- Growing interest in using MeV UED/UEM to solve the grand challenges in probing matter at ultrafast temporal and ultrasmall spatial scales
- Compact facility, yet with rich physics and great potential
- Potential of MeV UED/UEM fully demonstrated
- Still room to improve and lots of possibilities to explore

Thanks!